

Search Notes

Application/Control No.

10/626,574

Examiner

Christopher M. Keehan

Applicant(s)/Patent under
Reexamination

MISHIMA ET AL.

Art Unit

1712

SEARCHED

Class	Subclass	Date	Examiner
428	413	4/11/2005	CMK
	418		
	447		
	448		
	450		
	702		
524	441		
523	457		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/11/2005	CMK
Inventor name search		